

SLOVENSKI STANDARD oSIST prEN IEC 61810-7-40:2023

28-september-2023

Električni releji - Preskusi in meritve -7-40. del: Kratkostično testiranje

Electrical relays - Tests and Measurements - Part 7-40: Short circuit testing

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Ta slovenski standard je istoveten z: prEN IEC 61810-7-40:2023

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ICS:

29.120.70 Releji

Relays

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94/883/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:	
IEC 61810-7-40 ED1	
DATE OF CIRCULATION:	CLOSING DATE FOR VOTING:
2023-07-07	2023-09-29
SUPERSEDES DOCUMENTS:	
94/835/CD, 94/869/CC	

IEC TC 94 : ELECTRICAL RELAYS			
SECRETARIAT:	SECRETARY:		
Austria	Mr Bernhard Spalt		
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:		
TC 121,SC 121A			
	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.		
FUNCTIONS CONCERNED:			
EMC ENVIRONMENT	QUALITY ASSURANCE SAFETY		
SUBMITTED FOR CENELEC PARALLEL VOTING	NOT SUBMITTED FOR CENELEC PARALLEL VOTING		
Attention IEC-CENELEC parallel voting moards.iten.ai			
The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting. https://standards.iteh.ai/catalog/standards/sist/ab842d8b-e4d6-4a0b-94f1- The CENELEC members are invited to vote through the CENELEC online voting system.			

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TITLE:

Electrical relays – Tests and Measurements – Part 7-40: Short circuit testing

PROPOSED STABILITY DATE: 2026

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13			INTERN	ATIONAL ELECTRO	DTECHNICAL COM	MISSION
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16				Electrica	l relays –	
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19				Part 7-40: Shor	t circuit testing	
20 21				FORE	WORD	
22 23		1)			(IEC) is a worldwide orga es (IEC National Committees	anization for standardization s). The object of IEC is to p
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56	Th	ne te	xt of this Internati	onal Standard is based	on the following docum	ients:
				CD	Report on voting	
				94/835/CD	94/458/RVD	1
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Full information on the voting for the approval of this International Standard can be found in the 58 report on voting indicated in the above table. 59

This document has been drafted in accordance with the ISO/IEC Directives, Part 2. 60

A list of all parts of IEC 61810 series, published under the general title Electromechanical 61 elementary relays, can be found on the IEC website. 62

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⁶³ This International Standard is to be used in conjunction with IEC 61810-1:2015.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- 68 withdrawn,
- replaced by a revised edition, or
- amended.
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73	Electrical relays –
74	Tests and Measurements
75	
76	Part 7-40: Short circuit testing
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80 **1 Scope**

This part of IEC 61810-7 is used for testing along with the appropriate severities and conditions for measurements and tests designed to assess the ability of specimens to perform under expected conditions of transportation, storage and all aspects of operational use.

The object of this test is to define a standard test method for short circuit testing.

85 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

90 IEC 61810-1:2015, Electromechanical elementary relays – Part 1: General and safety 91 requirements

ISO 16750-1:2018, Road vehicles – Environmental conditions and testing for electrical and
 electronic equipment – Part 1: General NEC 61810-7-40:2023

https://standards.iteh.ai/catalog/standards/sist/ab842d8b-e4d6-4a0b-94f1-

ISO 16750-2:2012, Road vehicles – Environmental conditions and testing for electrical and
 electronic equipment – Part 2: Electrical loads

96 **3 Terms and definitions**

97 Clause 3 of IEC 61810-7-0 is applicable.

98 **3.1**

99 Short Circuit Protective Device (SCPD)

protective device, specified by the manufacturer, which has to be installed in the circuit in series
 with the device under test () in order to protect it against short-circuits only to cut the current

102 [SOURCE: IEC 60050-442:2010, 442-05-12, modified – modification of the definition]

103 **3.2**

104 Control Switch (CS)

105 Device which is capable to connect and disconnect the short circuit under safe conditions to 106 ensure full disconnection.

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1084Test procedure

109 **4.1 Purpose**

110 The test shall evaluate the relay short circuit capacity.



The Short Circuit Protective Device (SCPD) of the power source (including the primary and secondary protective devices) shall ensure that the short circuit prospective current could flow uninfluenced at least four half waves for AC or 20 ms for DC for the calibration shot.

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133 4.2.2 Preconditioning

The relay may be preconditioned several times before test, at no load or at any current not exceeding the rated current. The preconditioning (if any) shall be mentioned in the test record.

136 4.2.3 Test circuit calibration

- For the circuit calibration the DUT shall be bridged as close as possible to the DUT. However, the bridge shall have the same length and cross-section as the bridged wiring path.
- 139 The current form shall be recorded and shall be part of the test record.

140 4.2.4 Test procedure and/or sequence

- The procedure and/or sequence shall be selected in accordance with the application. However, the DUT shall be operated and monitored in accordance with Figure 2 of IEC 61810-0.
- 143 Examples for typical sequences are given as followed:
- SCPD is used:
- 145 CS closed \rightarrow DUT make into fault condition \rightarrow SCPD break
- 146 DUT is closed, → make is carried out by CS → SCPD break
- 147 No SCPD is present
- 148 DUT is closed → make and break is carried out by CS for a specific time
- 149 DUT make into fault condition; break is carried out by control switch after a specific time
- DUT is closed, make is carried out by control switch, break is carried out by DUT after a specific time and itch arctatolog/standards/sist/ab842d8b-e4d6-4a0b-94f1
- DUT has SCPD functions<sup>72660805/osist-pren-iec-61810-7-40-202.
 </sup>
- 153 DUT make into and break fault condition
- 154 DUT is closed, make is carried out by control switch, DUT with SCPD function break
- 155 And maybe combinations out of these.
- Unless otherwise specified, the short-circuit current shall applied at least 3 times on the sameDUT and the time between each shoot shall be not less than 60s.
- NOTE In case that a SCPD was used and must be renewed for the next shoot the time could be potentially much longer as.
- 160 For each test a new sample could be used.
- 161 **4.3 Test conditions**
- 162 The application (standard) specifies the following conditions:
- 163 Test sequence
- Number of test samples;
- energization conditions: if other than the rated coil voltage;
- polarity of contact;
- 167 test voltage;
- 168 test current;
- 169 short-circuit current time;

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- Number of applied short circuit current
- Used SCPD (specification of the SCPD), if applicable

172 **5 Evaluation**

After the short-circuit test, the relay shall fulfil the requirements given by the application standard or defined by the manufacturer.

As example: after the short circuit test the DUT shows no function (like: operate and / or relaese) anymore but enclosure is undamaged (no life parts are touchable):

177 If basic insulation is required, dielectric test according to IEC 61810-7-4 is required.

The test conditions shall be mentioned in the test report. If the test conditions are valid for all products/applications, then the test conditions shall be added to the datasheet/specification.

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